S	earcl	h Notes	;

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,617	KIM ET AL.	
Examiner	Art Unit	_
Joseph Haley	2653	

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Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED		
Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see attached EAST serach notes	1/11/2006	JRH	
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